

Applicati n N .	Applicant(s)
10/721,397	AUTREY ET AL.
Examiner	Art Unit
Thuy Pardo	2165

	SEARCHED					
Class	Subclass	Date	Examiner			
704	8	2/1/05	185			
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
707	8	2/1/05	185			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST	2/1/05	15		
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